



Page 1 of 1 ATTY. DOCKET NO. SERIAL NO. U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 15768 (V201-0675) INFORMATION DISCLOSURE APPLICANT Richard W. St. John et al. STATEMENT BY APPLICANT **GROUP** FILING DATE **U.S. PATENT DOCUMENTS** FILING DATE SUBCLASS CLASS DOCUMENT DATE NAME **EXAMINER** IF APPROPRIATE NUMBER INITIAL 7/11/00 Henry et al. 6,087,918 6,114,933 9/5/00 Widiger et al. 1178,957 617895 1/30/01 Widiger et al. FOREIGN PATENT DOCUMENTS TRANSLATION CLASS SUBCLASS COUNTRY DATE **EXAMINER** DOCUMENT ΝÓ YES NUMBER INITIAL OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) DATE CONSIDERED 13-29-03 Mother EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through

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Page 1 of 1 U.S. DEPARTMENT OF COMMERCE ATTY. DOCKET NO. SERIAL NO. PATENT AND TRADEMARK OFFICE 15768 (V201-0675) 10/035,685 INFORMATION DISCLOSURE STATEMENT BY APPLICANT Richard W. St. John et al. FILING DATE GROUP **DECEMBER 26,2001** 2832 **U.S. PATENT DOCUMENTS EXAMINER** DOCUMENT DATE NAME CLASS SUBCLASS FILING DATE INITIAL NUMBER IF APPROPRIATE 3,685,662 08/22/1972 Varon et al. 4,688,872 08/25/1987 Pohl 4,826,120 05/02/1989 Newton et al. 04/21/1992 5,106,143 Soeters 5,493,158 02/20/1996 **Daniels** 6,302,361 10/16/2001 Schaefer et al. 6,116,566 09/12/2000 Brown et al. FOREIGN PATENT DOCUMENTS **EXAMINER** DOCUMENT DATE COUNTRY CLASS SUBCLASS TRANSLATION INITIAL NUMBER YES B 05/11/1983 United Kingdom UK 2108318 EP 0321120 06/21/1989 European DE 3102533 10/21/1982 Germany FR 2617573 01/06/1989 France FR 2655386 06/07/1991 France OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Morror 18-29-03 DATE CONSIDERED EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through

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